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(54) CLEANING OF SEMICONDUCTOR SUBSTRATE

MANUFACTURE OF SEMICONDUCTOR DEVICE

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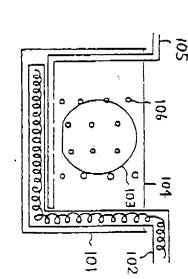
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PURPOSE: To reduce cost, to improve producibility and to stabilize quality of containing ozone to ammonia water solution. a semiconductor device by cleaning a substrate surface while adding gas

CONSTITUTION: Mixture solution 104 of aqueous ammonia and pure water is such as mixture gas 106 of ozone and oxygen is let out of a tube 105 which heated by a heater 102 in a chemical solution tank 101. Gas containing ozone is introduced below the chemical tank 101 and is made to impinge on the surface

of an Si substrate 103 for cleaning.



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